

**Search Notes**

Application/Control No.

10/784,446

Examiner

Krisna Lim

Applicant(s)/Patent under  
Reexamination

EYAL, AVIV

Art Unit

2153

**SEARCHED**

Class	Subclass	Date	Examiner
709	223, 231, 245	12/30/2006	KL
707	10	12/30/2006	KL
345	327	12/30/2006	KL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR